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EXAMINER'S AMENDMENT

1. An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

Authorization for this examiner's amendment was given in a telephone interview with Adam Rehm on 10/6/09.

The application has been amended as follows:

Claims 7-15 are cancelled.

DETAILED ACTION

Election/Restrictions

2. Claim 4 is allowable. The restriction requirement, as set forth in the Office action mailed on 1/10/08, has been reconsidered in view of the allowability of claims to the elected invention pursuant to MPEP § 821.04(a). The restriction requirement is hereby withdrawn as to any claim that requires all the limitations of an allowable claim. Claim 4, directed to species I no longer withdrawn from consideration because the claim(s) requires all the limitations of an allowable claim. In view of the above noted withdrawal of the restriction requirement, applicant is advised that if any claim presented in a continuation or divisional application is anticipated by, or includes all the limitations of, a claim that is allowable in the present application, such claim may be subject to

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provisional statutory and/or nonstatutory double patenting rejections over the claims of the instant application.

Once a restriction requirement is withdrawn, the provisions of 35 U.S.C. 121 are no longer applicable. See *In re Ziegler*, 443 F.2d 1211, 1215, 170 USPQ 129, 131-32 (CCPA 1971). See also MPEP § 804.01.

Allowable Subject Matter

- 3. Claims 1-2, 4-6, 21-25 allowed.
- 4. The following is an examiner's statement of reasons for allowance: The prior art fails to teach a solid state imaging device comprising an imaging area having a plurality of unit cells each including a group of a predetermined number of pixels where a full-face signal line is shared by the pixels and driving the full-face signal line allows the signal to be read out from each pixel, wherein the full-face signal line surrounds each of the plurality of unit cells, serves as a light shielding film, and has an opening corresponding to a light receiving surface for every pixel. Additionally, the prior art fails to teach a full-face signal line connected to drains of the reset unit and amplifying unit wherein the full-face selection signal passing through the full-face signal line is changed between an active state and a non-active state.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to AMY HSU whose telephone number is (571)270-3012. The examiner can normally be reached on M-F 8am-6pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Lin Ye can be reached on 571-272-7372. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

/Lin Ye/ Supervisory Patent Examiner, Art Unit 2622

/Amy Hsu/ Examiner, Art Unit 2622 10/6/09